

N-Channel 300 V (D-S) Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)			
300	2.3 at V _{GS} = 10 V	0.56			

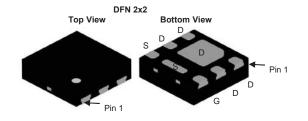
FEATURES

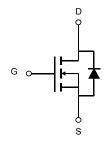
- DT-Trench Power MOSFET
- Ultra Small DFN2X2 Chipscale Packaging Reduces Footprint Area



APPLICATIONS

- Power management functions
- · Battery Operated Systems





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_A = 25 ^{\circ}\text{C}$) Parameter		Symbol Limit		Unit	
Drain-Source Voltage		V _{DS}	300		
Gate-Source Voltage		V _{GS}	± 20	V	
<u> </u>	T _C = 25 °C		0.55ª		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	1 . [0.45 ^a		
Continuous Diain Current (1) = 130 C)	T _A = 25 °C	- I _D -	0.13 ^{a, b, c}		
	T _A = 70 °C		0.07 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	2		
Continuous Source-Drain Diode Current	T _C = 25 °C		0.55 ^a		
Continuous Source-Diam Diode Current	T _A = 25 °C	I _S	0.13 ^{b, c}		
	T _C = 25 °C		0.66		
Maximum Power Dissipation	T _C = 70 °C	P_{D}	0.42	w	
Maximum Power Dissipation	T _A = 25 °C] '' [0.15 ^{b, c}	VV	
	T _A = 70 °C		0.09 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}			260	- 'C	

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^b	t ≤ 5 s	R _{thJA}	185	220	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	8.8	15			

Notes:

- a. Package limited
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. The DFN2X2 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

Rev. 1.0 1



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$	300			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	$\Delta V_{DS}/T_{J}$ $I_{D} = 250 \mu A$		203		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	η = 250 μΑ		- 9.5		mv/·C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	1.0		2.8	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zarra Cata Valta da Dunia Comunat	I _{DSS}	V _{DS} = 300 V, V _{GS} = 0 V			1		
Zero Gate Voltage Drain Current		V _{DS} = 240 V, V _{GS} = 0 V, T _J = 55 °C			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	0.55			Α	
	В	$V_{GS} = 10 V, I_D = 0.3 A$		2.3	4		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 0.3 \text{ A}$		2.8	5	Ω	
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 24 \text{ V}, I_D = 0.3 \text{ A}$		0.3		S	
Dynamic ^b					•		
Input Capacitance	C _{iss}			210		pF	
Output Capacitance	C _{oss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz		77			
Reverse Transfer Capacitance	C _{rss}			11			
Total Gate Charge	Qg			9		nC	
Gate-Source Charge	Q_{gs}	$V_{DS} = 150 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 0.3 \text{ A}$		1.3			
Gate-Drain Charge	Q _{gd}			0.5			
Gate Resistance	R _g	f = 1 MHz		2.9		Ω	
Turn-On Delay Time	t _{d(on)}			6		ns	
Rise Time	t _r	V 450 V D 4.0		10			
Turn-Off Delay Time	t _{d(off)}	$V_{DD} = 150 \text{ V}, R_L = 1 \Omega$ $I_D \cong 0.3 \text{ A}, V_{GEN} = 10 \text{ V}, R_q = 1\Omega$		35			
Fall Time	t _f	1D = 0.0 A, VGEN - 10 V, 11g - 152		20			
Turn-On Delay Time	t _{d(on)}			12			
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{I} = 1 \Omega$		17			
Turn-Off Delay Time	t _{d(off)}	$I_{D} \cong 0.3 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_{a} = 1\Omega$		57			
Fall Time	t _f	D = 6.67., * GEN **, **.g		41			
Drain-Source Body Diode Characteristic	cs						
Continuous Source-Drain Diode Current	Is	T _C = 25 °C			0.3	A	
Pulse Diode Forward Current	I _{SM}				2		
Body Diode Voltage	V_{SD}	I _S = 0.3 A, V _{GS} = 0 V		0.7	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			29		ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 0.3 A, dl/dt = 100 A/μs, T _J = 25 °C		50		nC	
Reverse Recovery Fall Time	t _a	$\frac{1}{1} = 0.3 \text{ A}, \text{ ul/ul} = 100 \text{ A/} \mu \text{s}, \text{ I}_{J} = 25 \text{ C}$		18		ns	
Reverse Recovery Rise Time	t _b]		22			

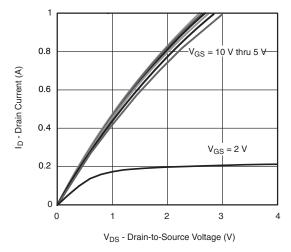
Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

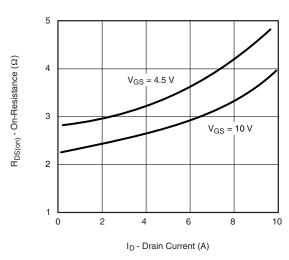
a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.



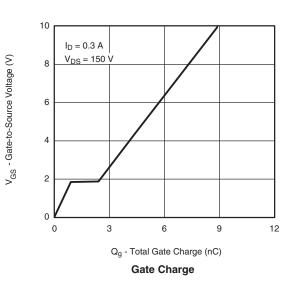
TYPICAL CHARACTERISTIC (25 °C, unless otherwise noted)

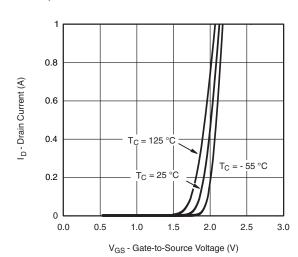


Output Characteristics

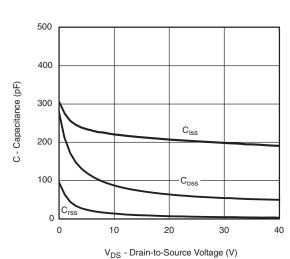


On-Resistance vs. Drain Current and Gate Voltage

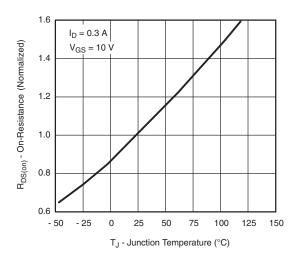




Transfer Characteristics



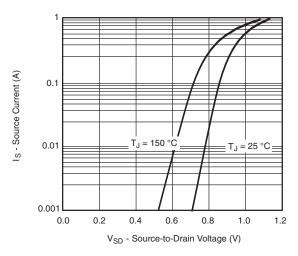
Capacitance



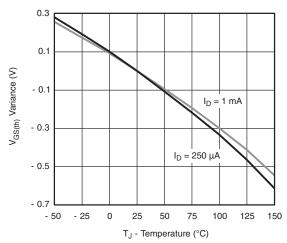
On-Resistance vs. Junction Temperature



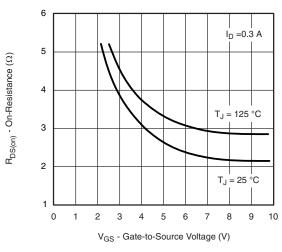
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



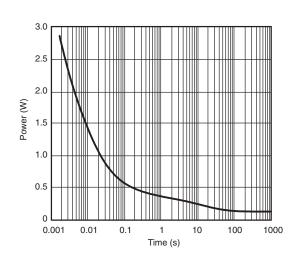
Source-Drain Diode Forward Voltage



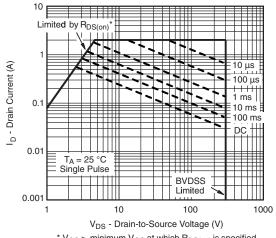
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power (Junction-to-Ambient)

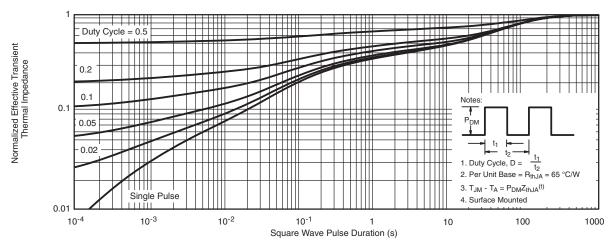


* $V_{GS} > \mbox{ minimum } V_{GS}$ at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient



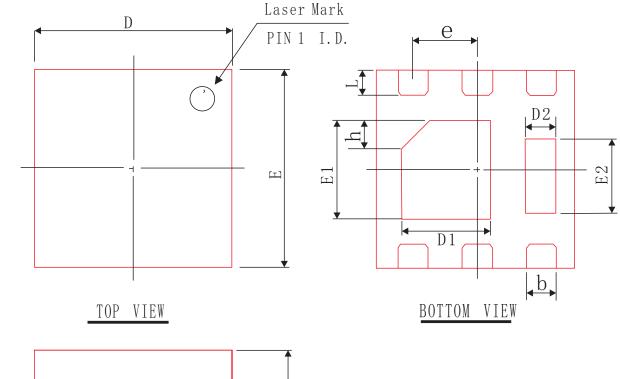
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

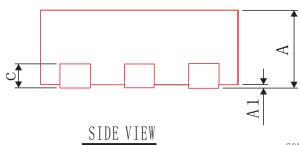


Normalized Thermal Transient Impedance, Junction-to-Ambient



DFN2x2-6L PACKAGE OUTLINE





COMMON DIMENSIONS (UNITS OF MEASURE=mm)

SYMBOL	MIN	NOM	MAX	
A	0.70	0.75	0.80	
A 1	0.00	0.02	0.05	
b	0.20	0.25	0.30	
D	1.95	2.00	2.07	
Е	1.95	2.00	2.07	
D1	0.80	0.90	1.00	
E1	0.90	1.00	1.10	
D2	0.20	0.30	0.40	
E2	0.65	0.75	0.85	
L	0.20	0.25	0.35	
h	0.20	0.25	0.30	
С	0.203 REF			
е	0 65 BSC			
A*	0.55	0.60	0.65	
A*	0.50	0.55	0.60	

A*: Other thicknesses

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